Scientific NIR-II / SWIR Cameras for Advanced Imaging and Spectroscopy Applications

New, Deeply Cooled InGaAs Cameras Provide Ultrahigh Sensitivity for Key Spectral Range

Introduction

For decades, x-ray and UV-vis-NIR detection methods have been used in various scientific, military, medical, and industrial applications. Although generally employed with success, these detection systems nonetheless still possess some limitations when utilized for such types of work.

Effectively leveraging the good sample penetration afforded by x-rays, for example, can prove difficult for personnel in the field owing to the need for a compact, high-power x-ray tube, as well as a basic lack of system portability. Alternatively, UV and visible wavelengths are quite easily detectable using silicon-based CCD technologies but are unable to penetrate samples deeply enough due to reflection and scattering of light.

CCD cameras can detect NIR-I wavelengths between 750 and 1060 nm, providing slight penetration into samples (~3 mm), but above this threshold the silicon itself is transparent to light. Such CCD camera systems have therefore found somewhat limited use in military (e.g., surveillance) and commercial (e.g., inspection) applications.

The NIR-II window / short-wavelength infrared (SWIR) range, which extends to 1700 nm, achieves penetration to ~10 mm (see Figure 1). Spurred on by the development of SWIR-sensitive InGaAs and InSb detectors, work in this range has opened up a new world of scientific, military, medical, and industrial applications.

Figure 1.


“NIRvana InGaAs cameras are ideal for many leading-edge NIR-II / SWIR applications, including semiconductor failure analysis, solar cell inspection, nondestructive testing, astronomy, small-animal imaging, and singlet oxygen detection.”
Unfortunately, early NIR-II / SWIR detection systems also still had key limitations for many of the aforementioned applications. Insufficiencies associated with camera system linearity, noise performance, and synchronization with external equipment, as well as the lack of sufficient flexibility to control exposure times all presented critical obstacles.

This application note will present several examples from the extensive set of NIR-II / SWIR applications facilitated by newly developed, deeply cooled, scientific InGaAs cameras (see Figure 2) from Princeton Instruments.

**Figure 2.**
Princeton Instruments’ new NIRvana® scientific cameras feature a thermoelectrically or LN-cooled 640 x 512 InGaAs detector and offer excellent sensitivity in the NIR-II / SWIR spectral range.

**Industrial Imaging: Semiconductor Failure Analysis & Solar Cell Inspection**

Our first example of imaging performed in the NIR-II / SWIR range for a high-tech industry pertains to semiconductor failure analysis (SFA). The image displayed in Figure 3 is an optical and emission overlay of control circuits (i.e., 22 nm technology SRAM circuits powered at 800 mV) acquired using Princeton Instruments’ thermoelectrically cooled NIRvana-ST InGaAs camera.

**Figure 3.**
Optical and emission overlay of control circuits: 22 nm technology SRAM circuits powered at 800 mV. Image acquired at 100x using a Princeton Instruments NIRvana:640ST InGaAs camera. Courtesy of Dr. Michael Jupina, Checkpoint Technologies, LLC (San Jose, California).
Another example of the importance of the NIR-II / SWIR range relates to the solar cell manufacturing process, where large-format, deeply cooled InGaAs FPA cameras from Princeton Instruments enable researchers to observe photoluminescence (PL) emission at SWIR wavelengths and rapidly obtain more detailed information about defects within multicrystalline silicon solar cells. See Figure 4.

The ability to quickly acquire PL imaging data in the defect band between 1300 and 1600 nm at any stage of the manufacturing process is expected to aid in the clearer identification of a specific defect’s material composition or impurity. The data could also be utilized to better inform process modifications aimed at eliminating defects and improving the efficiency of individual solar cells. In this way, PL imaging in the NIR-II / SWIR range via state-of-the-art InGaAs FPA cameras can help increase yield as well as reduce manufacturing costs.

Medical Imaging: Small-Animal Research / Drug Discovery
In recent years, research groups around the world have been developing different agents to be used with the NIR-II / SWIR window in small-animal imaging for preclinical research, with the ultimate goal of earlier disease detection in human patients. Most of these approaches are based on one of three primary technologies: single-walled carbon nanotubes (SWNTs), rare-earth–doped phosphors, or quantum dots.

Each approach utilizes a similar experimental setup, whose main elements are NIR-I illumination, a specimen (e.g., a mouse), and a camera system to detect emitted light in the wavelength range from 1100 to 1650 nm. See Figure 5.
Figure 6 presents NIR-I and NIR-II / SWIR images of blood vessels in a mouse. The NIR-I image shown in Figure 6a was acquired using a scientific, silicon-based CCD camera. The NIR-II / SWIR image shown in Figure 6b was acquired using a scientific InGaAs camera (OMA-2D:320) from Princeton Instruments.

(a) NIR-I fluorescence image (top) and cross-sectional fluorescence intensity profile (bottom) along red dashed line of a mouse injected with SWNT-IRDye-800 conjugates. Gaussian fit to the profile is shown in red dashed curve. (b) NIR-II / SWIR fluorescence image (top) and cross-sectional fluorescence intensity profile (bottom) along red dashed line of a mouse injected with SWNT-IRDye-800 conjugates. Gaussian fit to the profile is shown in red dashed curve. Data courtesy of Prof. Hongjie Dai, Stanford University.

All images acquired in the NIR-I region employing IRDye-800 fluorescence showed indistinct vascular anatomy within the mouse; however, the detection of SWNT fluorescence in the NIR-II / SWIR window provided substantially improved spatial resolution of vessels in the same mouse at all magnifications.

Astronomy & Spectroscopy
Further examples of the utility of the NIR-II / SWIR spectral range can be seen in the areas of astronomy and spectroscopy. The two images of sunspots displayed in Figure 7 were acquired using a Princeton Instruments NIRvana:640 InGaAs camera at Yunnan Observatories’ Fuxian Lake Solar Observing Station in China.

Figure 7. Sunspot images taken at 1565.3 nm (left) and 1083.0 nm (right) using a Princeton Instruments NIRvana:640 InGaAs camera with the New Vacuum Solar Telescope at the Fuxian Lake Solar Observing Station. Courtesy of Yunnan Observatories, Chinese Academy of Sciences.
The main instrument hosted by the station is the New Vacuum Solar Telescope (NVST), a 1 meter IR solar observation telescope. The primary scientific mission of NVST astronomers consists of obtaining high-resolution images and spectra of the sun at wavelengths ranging from 0.3 to 2.5 µm for the purpose of studying fine structures of solar magnetic fields, as well as investigating evolutionary processes in high temporal and spatial resolution.

Figure 8 presents a final example of work in the NIR-II / SWIR range. At Brown University, a NIRvana:640 InGaAs camera coupled to a high-precision spectrograph from Princeton Instruments was utilized to produce a topographical rendering of energy-momentum-resolved spectroscopy.

**Enabling Technology**

The NIRvana family of InGaAs cameras from Princeton Instruments differentiates itself from other InGaAs cameras via a number of scientific performance features, including deep cooling, low dark noise, high linearity, low read noise, high frame rates, intelligent software, and precision control over integration times.

First and foremost, either maintenance-free thermoelectric cooling or liquid nitrogen can be employed to chill the NIRvana’s two-dimensional 640 x 512 InGaAs FPA detector down as low as –85°C or –190°C, respectively. A proprietary cold shield design and vacuum technology facilitates the lowest possible dark noise, which helps increase sensitivity as well as preserve signal-to-noise ratio (SNR) for long exposure times.

Thermoelectrically cooled NIRvana cameras have the ability to expose from 2 µsec up to many minutes. LN-cooled NIRvana camera exposure times can range from 100 µsec up to 1 hour. Ultra-low-noise readout electronics help ensure good SNR even when the cameras are operated at their maximum full-frame readout rates (i.e., 110 full fps for thermoelectrically cooled cameras; 2.77 full fps for LN-cooled cameras). Furthermore, excellent system linearity means that NIRvana cameras are highly reliable for scientific research.
Princeton Instruments’ 64-bit LightField® software, available as an option, provides a powerful yet easy-to-use interface that puts real-time online processing capabilities at the researcher’s fingertips. NIRvana cameras can also be integrated into larger experiments using an available National Instruments LabVIEW® toolkit. Full triggering support is provided for synchronization with external equipment.

NIRvana InGaAs cameras are ideal for many leading-edge NIR-II / SWIR applications, including semiconductor failure analysis, solar cell inspection, nondestructive testing, astronomy, small-animal imaging, and singlet oxygen detection.

**Resources**

For additional information about Princeton Instruments NIRvana cameras, please visit: [www.princetoninstruments.com/products/imcam/nirvana](http://www.princetoninstruments.com/products/imcam/nirvana)

**References**


